

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: TOKUNAGA, Kenji  
Serial No.: Not yet assigned  
Filed: January 27, 2004  
For: METHOD OF PURGING WAFER RECEIVING JIG, WAFER  
TRANSFER DEVICE, AND METHOD OF MANUFACTURING  
SEMICONDUCTOR DEVICE

**INFORMATION DISCLOSURE STATEMENT**  
**UNDER 37 CFR 1.97 & 1.98**

Mail Stop DD  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

January 27, 2004

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

This information disclosure statement is being submitted with the new application.

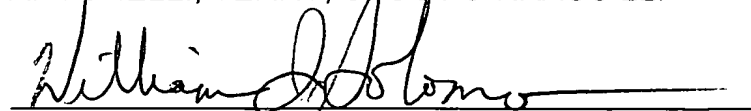
Although the documents listed on the attached form equivalent to Form PTO-1449 are not in the English language, the requirement of 37 CFR 1.98(a)(3) for a concise explanation of the relevance is satisfied by the discussion of the documents in the specification, for example, on pages two (2) and three (3).

It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of Antonelli, Terry, Stout & Kraus Deposit Account No. 01-2135 (Case: 843.43437X00), and please credit any excess fees to such deposit account.

Respectfully submitted,

ANTONELLI, TERRY, STOUT &amp; KRAUS LLP



William I. Solomon  
Registration No. 28,565

WIS/alb  
(703) 312-6600  
Attachments

<b>Form PTO-1449</b>	<b>U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE</b>	<b>ATTY. DKT. NO.</b> 843.43437X00	<b>SERIAL NO.</b>
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use several sheets if necessary)		<b>APPLICANT</b> TOKUNAGA, Kenji	
		<b>FILING DATE</b> January 27, 2004	<b>GROUP</b>

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					

**FOREIGN PATENT DOCUMENTS**

Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AM	11-91864	04/06/1999	JP	B65D	85/86	X	
	AN	6-334019	12/02/1994	JP	H01L	21/68	X	
	AO	9-246354	09/19/1997	JP	H01L	21/68	X	
	AP							
	AQ							
	AR							
	AS							
	AT							

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AU	SEMI Standard E57, E1.9, E47.1
	AV	
	AW	
	AX	
	AY	
	AZ	
<b>Examiner</b>		<b>Date Considered</b>